

**12A 4Quadrants TRIACs**

**Product Summary**

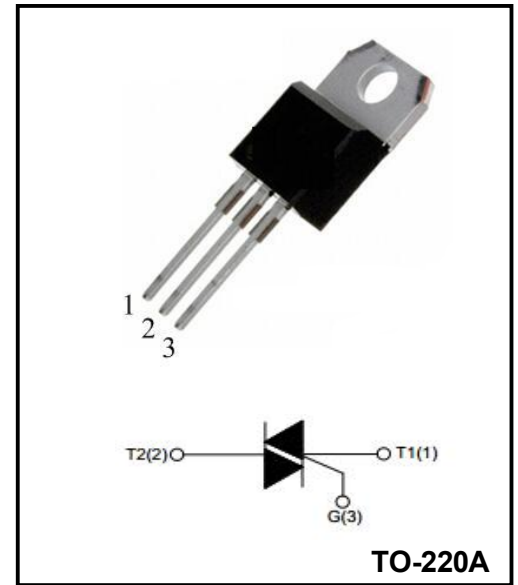
Symbol	Value	Unit
$I_{T(AV)}$	12	A
$V_{DRM} V_{RRM}$	600/800	V
$V_{TM}$	1.55	V

**Features**

NPNP five-layer structure of silicon bidirectional devices; with independent intellectual property rights of single-sided digging technology, table Glass passivation process; multi-layer metallized electrodes on the back; with high blocking voltage and high temperature stability.

**Application**

vacuum cleaners, power tools and other motor speed controllers; solid state relays; heating controllers (temperature regulation); other phase control circuits.



**Order Information**

Part Number	Package	Marking	Packing	Packing Quantity
BTA12	TO-220A	BTA12- 800E XXXX	box	1000PCS/box
BTA12	TO-220A	BTA12- 800C XXXX	box	1000PCS/box
BTA12	TO-220A	BTA12- 800B XXXX	box	1000PCS/box

**Absolute maximum ratings (Ta=25°C unless otherwise noted)**

Parameter	Symbol	Value	Unit
Repetitive peak off-state voltage	$V_{DRM}$	600/800	V
Repetitive peak reverse voltage	$V_{RRM}$	600/800	V
RMS on-state current	$I_T(RMS)$	12	A
Non repetitive surge peak on-state current (full cycle, F=50Hz)	$I_{TSM}$	120	A
$I^2t$ value for fusing (tp=10ms)	$I^2t$	78	A <sup>2</sup> s
Critical rate of rise of on-state current ( $I_G = 2 \times I_{GT}$ )	$di_T/dt$	I - II - III	50
		IV	10
Peak gate current	$I_{GM}$	2	A
Average gate power dissipation	$P_G (AV)$	0.5	W
Junction Temperature	$T_J$	-40 ~+125	°C
Storage Temperature	$T_{STG}$	-40 ~+150	°C

**Electrical characteristics (TA=25°C, unless otherwise noted)**

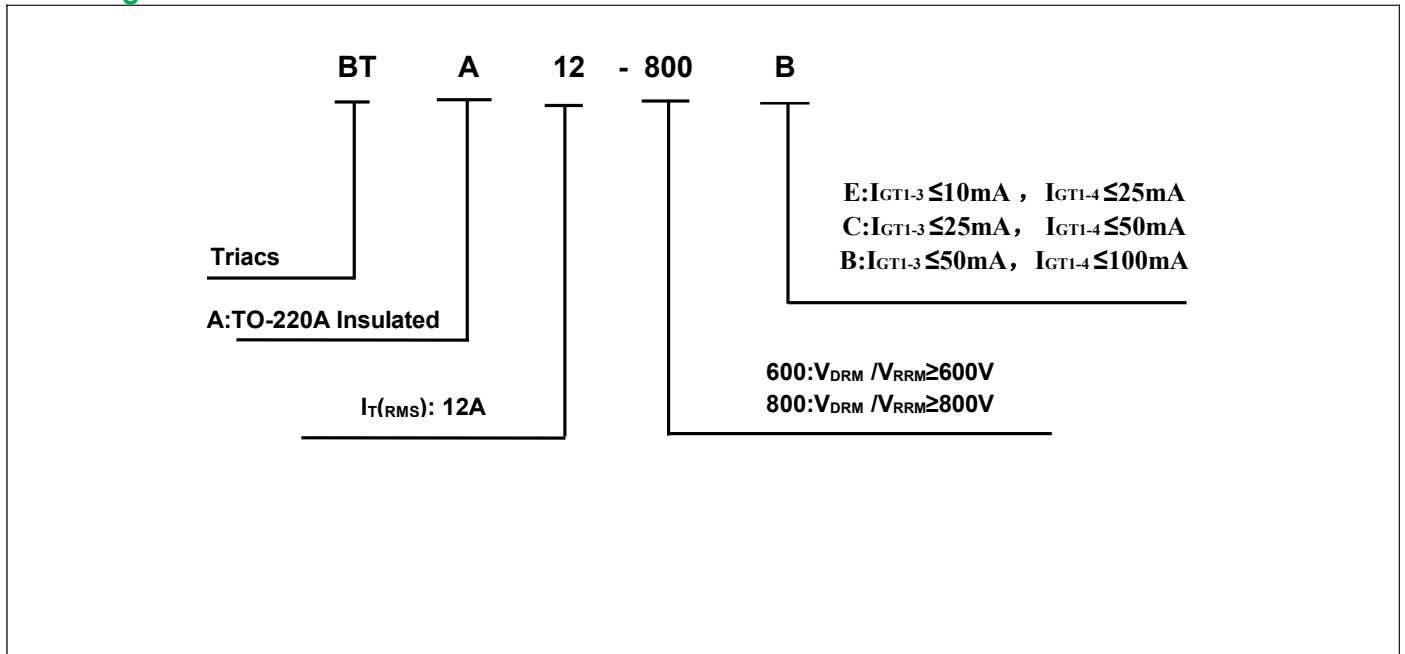
Parameter	Symbol	Test Condition	Value			Unit	
			E	C	B		
Gate trigger current	$I_{GT}$	$V_D=12V$ $I_T=0.1A$ $T_J=25^\circ C$	I-II-III	$\leq 10$	$\leq 25$	$\leq 50$	<b>mA</b>
			IV	$\leq 25$	$\leq 50$	$\leq 100$	
Gate trigger voltage	$V_{GT}$	I-II-III-IV	$\leq 1.3$			<b>v</b>	
Gate non-trigger voltage	$V_{GD}$	$V_D=V_{DRM}$ $T_J=125^\circ C$	$\geq 0.2$			<b>v</b>	
Holding current	$I_H$	$V_D=12V$ $I_{GT}=0.1A$ $T_J=25^\circ C$	I-II-III-IV	$\leq 25$	$\leq 30$	$\leq 50$	<b>mA</b>
latching current	$I_L$		I-III-IV	$\leq 30$	$\leq 40$	$\leq 50$	<b>mA</b>
			II	$\leq 40$	$\leq 60$	$\leq 80$	
Critical-rate of rise of commutation voltage	$dV_D/dt$	$V_D=67\%V_{DRM}$ , $T_J=125^\circ C$	$\geq 100$	$\geq 500$	$\geq 1000$	<b>V/<math>\mu s</math></b>	

**STATIC CHARACTERISTICS**

Forward "on" voltage	$V_{TM}$	$I_{TM}=17A$ $t_p=380\mu s$	$\leq 1.55$			<b>v</b>	
Repetitive Peak Off-State Current	$I_{DRM}$	$V_D=V_{DRM}/V_{RRM}$	$T_J=25^\circ C$	$\leq 5$	$\leq 5$	$\leq 5$	<b><math>\mu A</math></b>
Repetitive Peak Reverse Current	$I_{RRM}$		$T_J=125^\circ C$	$\leq 1$	$\leq 1$	$\leq 1$	<b>mA</b>

**THERMAL RESISTANCES**

Thermal resistance	$R_{th(j-c)}$	Junction to case(AC)	2.1	<b><math>^\circ C/W</math></b>
	$R_{th(j-a)}$	Junction to ambient	60	<b><math>^\circ C/W</math></b>

**Ordering Information**


Typical Characteristics

FIG.1: Maximum power dissipation versus RMS on-state current (full cycle)

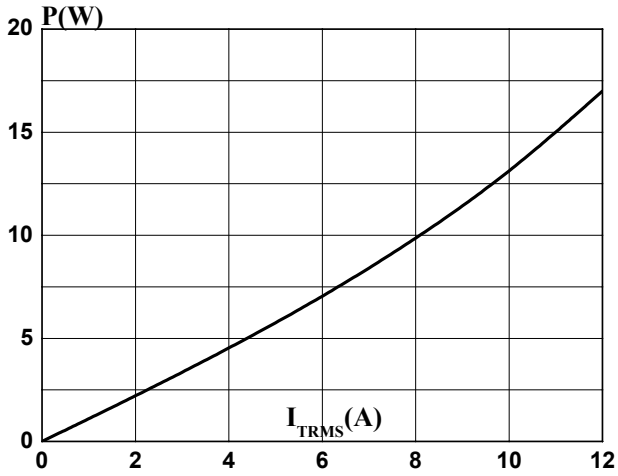


FIG.3: Surge peak on-state current versus number of cycles

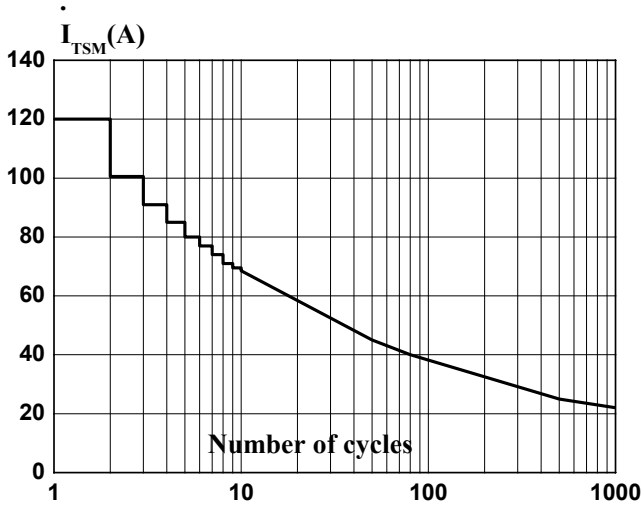


FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$

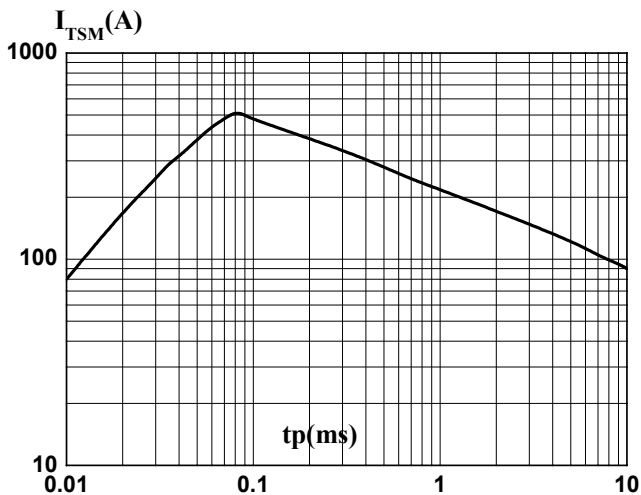


FIG.2: RMS on-state current versus case temperature (full cycle)

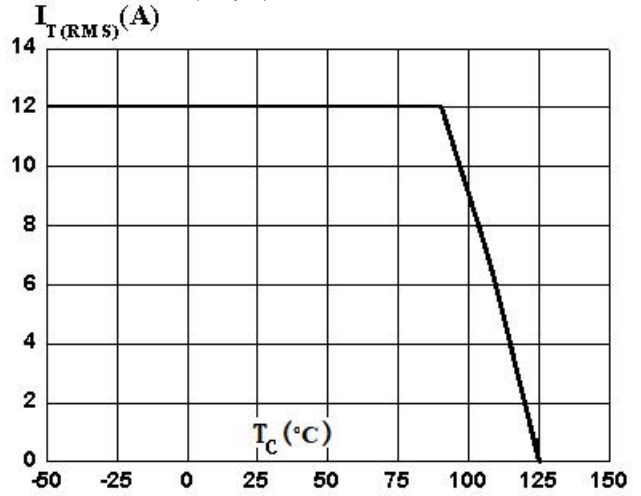


FIG.4: On-state characteristics (maximum values)

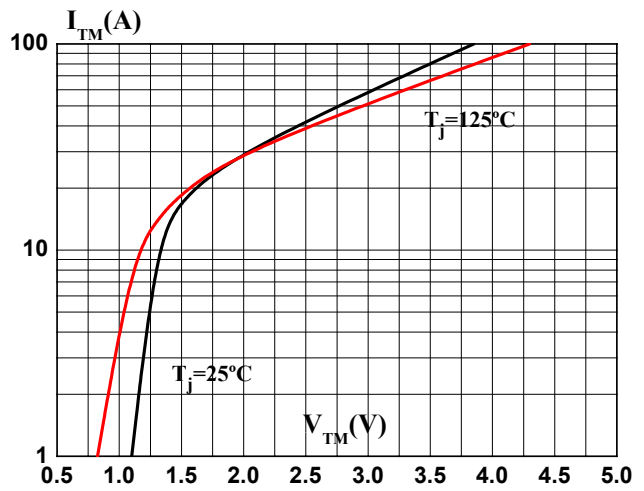
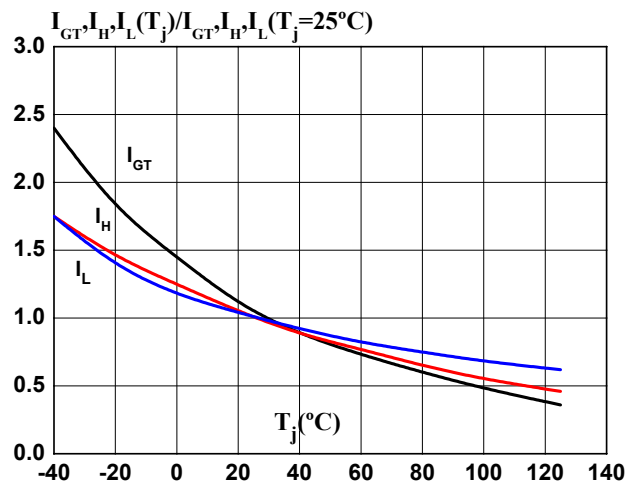
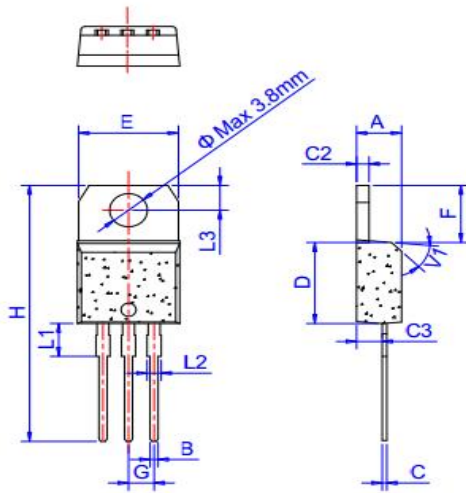


FIG.6: Relative variations of gate trigger current, holding current and latching current versus junction temperature (typical values)



Package Information

TO-220A



TO-220A

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.40		4.60	0.173		0.181
B	0.61		0.88	0.024		0.035
C	0.46		0.70	0.018		0.028
C2	1.21		1.32	0.048		0.052
C3	2.40		2.72	0.094		0.107
D	8.60		9.70	0.339		0.382
E	9.80		10.4	0.386		0.409
F	6.55		6.95	0.258		0.274
G		2.54			0.1	
H	28.0		29.8	1.102		1.173
L1		3.75			0.148	
L2	1.14		1.70	0.045		0.067
L3	2.65		2.95	0.104		0.116
V1		45°			45°	